

TOSHIBA Transistor Silicon PNP Triple Diffused Type

2SA1924

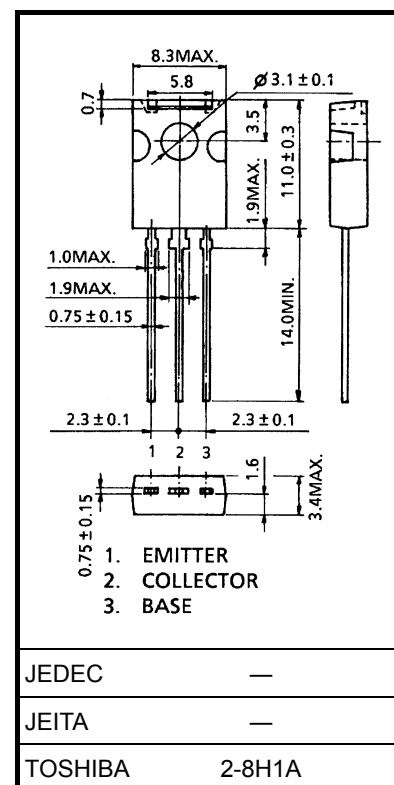
High-Voltage Switching Applications

Unit: mm

- High breakdown voltage: $V_{CEO} = -400\text{ V}$
- Low saturation voltage: $V_{CE(sat)} = -1\text{ V (max)}$
($I_C = -100\text{ mA}$, $I_B = -10\text{ mA}$)
- Collector metal (fin) is fully covered with mold resin.

Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$)

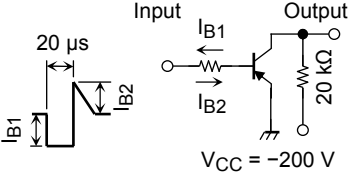
Characteristics		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	-400	V
Collector-emitter voltage		V_{CEO}	-400	V
Emitter-base voltage		V_{EBO}	-7	V
Collector current	DC	I_C	-0.5	A
	Pulse	I_{CP}	-1	
Base current		I_B	-0.25	A
Collector power dissipation	$T_a = 25^\circ\text{C}$	P_C	1.5	W
	$T_c = 25^\circ\text{C}$		10	
Junction temperature		T_j	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55 to 150	$^\circ\text{C}$



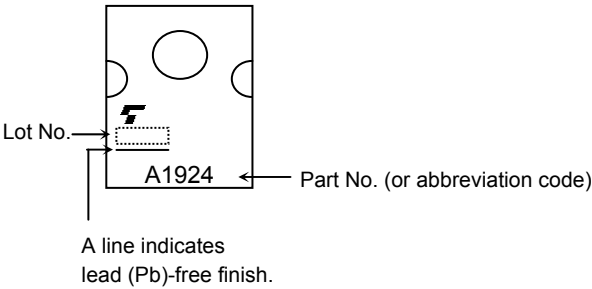
Weight: 0.82 g (typ.)

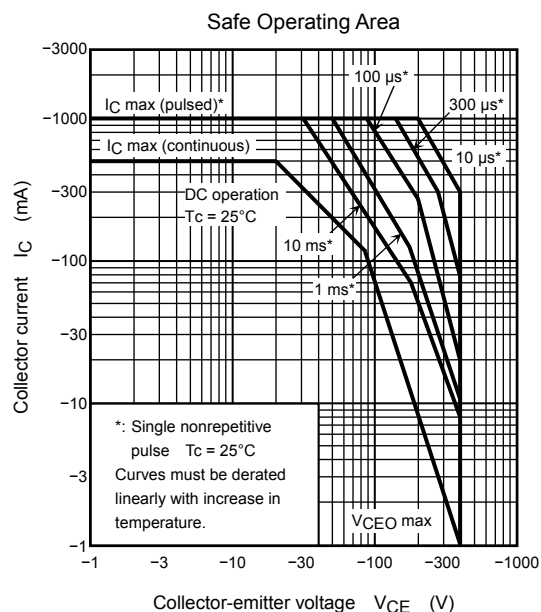
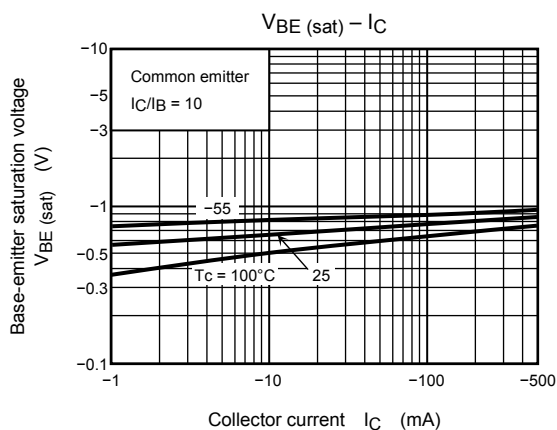
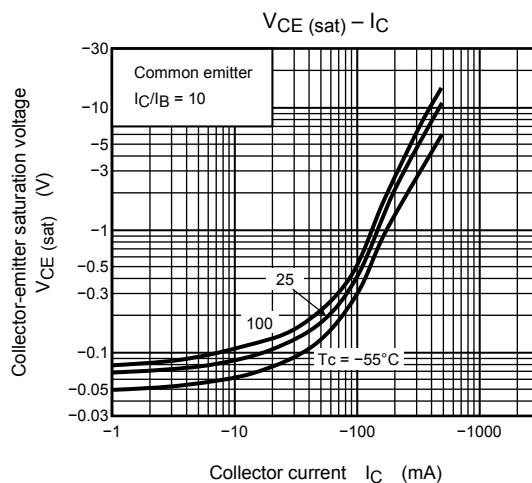
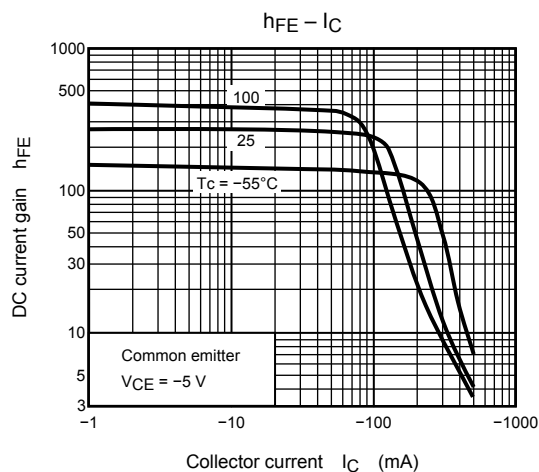
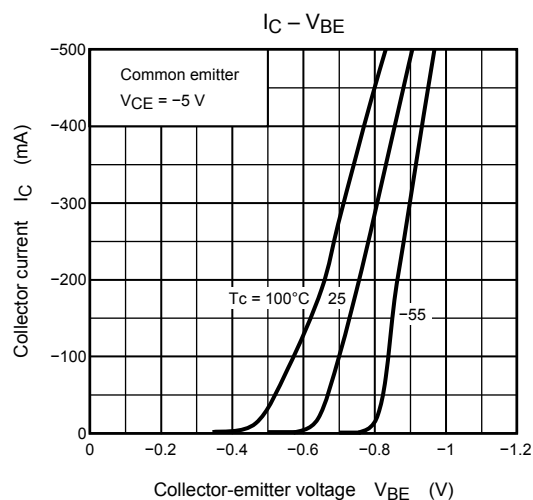
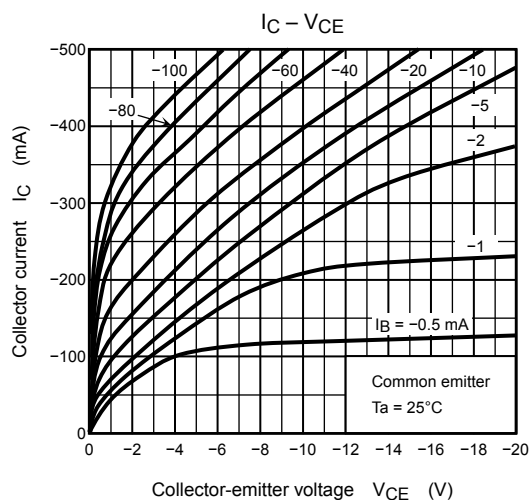
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Tc = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		ICBO	V _{CB} = -400 V, I _E = 0	—	—	-10	μA
Emitter cut-off current		IEBO	V _{EB} = -7 V, I _C = 0	—	—	-1	μA
Collector-emitter breakdown voltage		V _{CEO}	I _C = -10 mA, I _B = 0	-400	—	—	V
DC current gain		h _{FE} (1)	V _{CE} = -5 V, I _C = -20 mA	140	—	450	
		h _{FE} (2)	V _{CE} = -5 V, I _C = -100 mA	140	—	400	
Collector-emitter saturation voltage		V _{CE} (sat)	I _C = -100 mA, I _B = -10 mA	—	-0.4	-1.0	V
Base-emitter saturation voltage		V _{BE} (sat)	I _C = -100 mA, I _B = -10 mA	—	-0.76	-0.9	V
Transition frequency		f _T	V _{CE} = -5 V, I _C = -50 mA	—	35	—	MHz
Collector output capacitance		C _{ob}	V _{CB} = -10 V, I _E = 0, f = 1 MHz	—	18	—	pF
Switching time	Turn-on time	t _{on}	 I _{B1} = -10 mA, I _{B2} = 20 mA, duty cycle ≤ 1%	—	0.2	—	μs
	Storage time	t _{stg}		—	2.3	—	
	Fall time	t _f		—	0.2	—	

Marking





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20070701-EN GENERAL

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